



DUAL N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BVDSS	R _{DS(ON)} Max	I _D Max T _A = +25°C
	20mΩ @ V _{GS} = 10V	6.9A
30V	27mΩ @ V _{GS} = 4.5V	5.8A

Description and Applications

This MOSFET is designed to meet the stringent requirements of automotive applications. It is qualified to AEC-Q101, supported by a PPAP and is ideal for use in:

- Backlighting
- Power Management Functions
- DC-DC Converters

Features

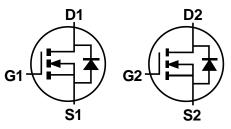
- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- The DMN3033LSDQ is suitable for automotive applications requiring specific change control; this part is AEC-Q101 qualified, PPAP capable, and manufactured in IATF 16949 certified facilities.

https://www.diodes.com/quality/product-definitions/

Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound;
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe;
 Solderable per MIL-STD-202, Method 208 (§3)
- Weight: 0.072grams (Approximate)





N-Channel MOSFET

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Ordering Information (Note 4)

Part Number	Case	Packaging
DMN3033LSDQ-13	SO-8	2,500/Tape & Reel

Notes:

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

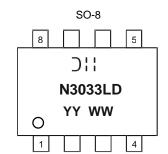
8 D1

6 D2

5 D2

- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information



⊃¦¦ = Manufacturer's Marking N3033LD = Product Type Marking Code YYWW = Date Code Marking YY = Year (ex: 20 = 2020) WW = Week (01 to 53)



Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

Chara	cteristic		Symbol	Value	Unit
Drain-Source Voltage		VDSS	30	V	
Gate-Source Voltage			V _{GSS}	±20	V
Drain Current (Note 5)	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	lo	6.9 5.8	Α
Pulsed Drain Current (Note 6)			IDM	30	Α

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 5)	P _D	2	W
Thermal Resistance, Junction to Ambient	Reja	62.5	°C/W
Operating and Storage Temperature Range	TJ, TSTG	-55 to +150	°C

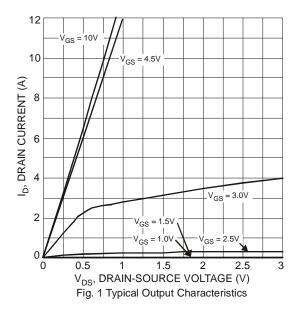
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BVDSS	30	_	_	V	$V_{GS} = 0V, I_{D} = 250\mu A$	
Zero Gate Voltage Drain Current	IDSS	_	_	100	nA	$V_{DS} = 30V$, $V_{GS} = 0V$	
Cata Sauraa Laakaga	l	_	_	±100	nA	$V_{GS} = \pm 20V$, $V_{DS} = 0V$	
Gate-Source Leakage	Igss	_	_	1	μΑ	$V_{GS} = \pm 25V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V _{GS(TH)}	1		2.1	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	
Static Drain-Source On-Resistance	Descous		13	20	mΩ	$V_{GS} = 10V, I_{D} = 6.9A$	
Static Dialif-Source Off-Resistance	R _{DS(ON)}		22	27	11122	$V_{GS} = 4.5V, I_{D} = 5A$	
Forward Transconductance	G fs	_	7	_	S	$V_{DS} = 5V, I_{D} = 6.9A$	
Diode Forward Voltage (Note 7)	V_{SD}	0.5	_	1.2	V	$V_{GS} = 0V$, $I_S = 1A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	Ciss	_	725	_	pF	V _{DS} = 15V, V _{GS} = 0V f = 1MHz	
Output Capacitance	Coss	_	114	_	pF		
Reverse Transfer Capacitance	Crss	_	92	_	pF	T = TIMHZ	
Gate Resistance	Rg	_	0.89	_	Ω	$V_{GS} = 0V$, $V_{DS} = 0V$, $f = 1MHz$	
SWITCHING CHARACTERISTICS (Note 8)							
Total Gate Charge	Qg		6.4	_	nC	V _G S = 4.5V, V _D S = 15V, I _D =5A	
Total Gate Charge	Цg		13			$V_{GS} = 10V, V_{DS} = 15V, I_{D} = 6.9A$	
Gate-Source Charge	Qgs	_	1.9	_	nC	$V_{GS} = 4.5V$, $V_{DS} = 15V$, $I_{D} = 6.9A$	
Gate-Drain Charge	Q_gd	_	3.2	_	nC	$V_{GS} = 4.5V, V_{DS} = 15V, I_D = 6.9A$	
Turn-On Delay Time	tD(ON)	_	11	_	ns		
Turn-On Rise Time	t _R	_	7	_	ns	$V_{DD} = 15V, V_{GS} = 10V,$	
Turn-Off Delay Time	tD(OFF)		63		ns	$R_D = 1.8\Omega$, $R_G = 6\Omega$	
Turn-Off Fall Time	tF		30	_	ns		

Notes:

- 5. Device mounted on 2 oz. Copper pads on FR-4 PCB with $R_{\theta JA} = 62.5^{\circ}$ C/W.
- Delive midth ≤10μS, Duty Cycle ≤1%.
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing.





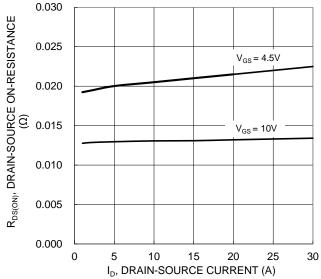


Fig. 3 Typical On-Resistance vs. Drain Current and Gate Voltage

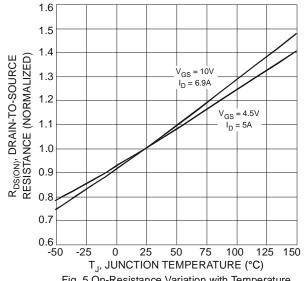
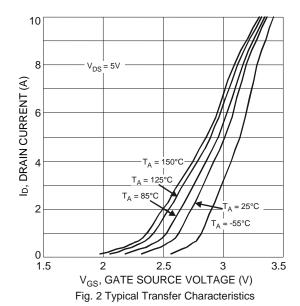
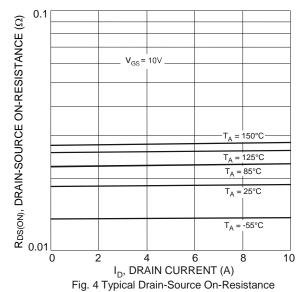


Fig. 5 On-Resistance Variation with Temperature



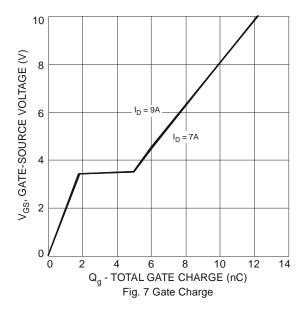


vs. Drain Current and Temperature 10,000 f = 1MHz C, CAPACITANCE (pF) 1,000 100 10 0 15 20 30

 V_{DS} , DRAIN-SOURCE VOLTAGE (V)

Fig. 6 Typical Capacitance





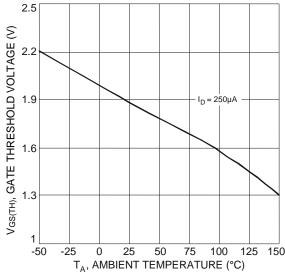
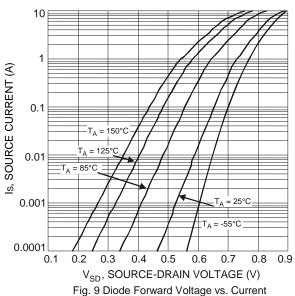


Fig. 8 Gate Threshold Variation vs. Ambient Temperature



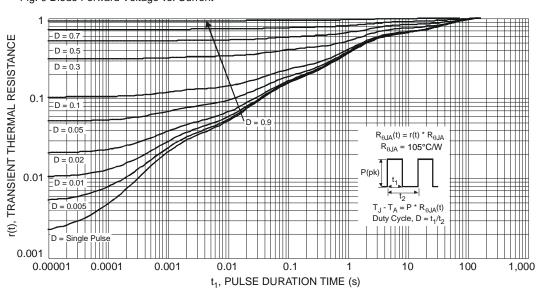


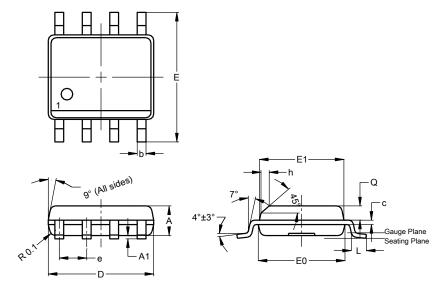
Fig. 10 Transient Thermal Response



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.



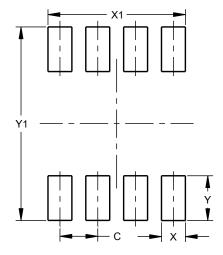


SO-8					
Dim	Min	Max	Тур		
Α	1.40	1.50	1.45		
A 1	0.10	0.20	0.15		
b	0.30	0.50	0.40		
С	0.15	0.25	0.20		
D	4.85	4.95	4.90		
Е	5.90	6.10	6.00		
E1	3.80	3.90	3.85		
EO	3.85	3.95	3.90		
е			1.27		
h			0.35		
٦	0.62	0.82	0.72		
Ø	0.60	0.70	0.65		
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

SO-8



Dimensions	Value (in mm)		
С	1.27		
Х	0.802		
X1	4.612		
Y	1.505		
Y1	6.50		



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